

SK TECH CO., LTD.

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Certificate	of	Comp	liance

SKTFCE-050910-072 **Test Report No.: NVLAP CODE:** 200220-0 SEJIN ELECTRON INC. Applicant: **Applicant Address:** 60-19, KASAN-DONG, KEUMCHON-KU, SEOUL, KOREA Manufacturer: **SEJIN ELECTRON INC.** Manufacturer 60-19, KASAN-DONG, KEUMCHON-KU, SEOUL, KOREA Address: **Product: Keyboard** FCC ID: GJJSKR-4200U Model No.: **SKR-4200U** Receipt No.: SKTEU05-0563 Date of receipt: Aug 26, 2005 Date of Issue: Sep 10, 2005 SK TECH CO., LTD. **Testing location:** 820-2, Wolmoon-Ri, Wabu-Up, Namyangju-Si, Kyunggi-Do, Korea **Test Standards:** ANSI C63.4 / 2003 **Rule Parts:** FCC part 15 Subpart B **Equipment Class: Class B Digital Device Peripheral**

Prepared by: S.Y.Ye Tested by: J.S.Hyun/Engineer Approved by: D.H.Kang

repared by: 5.1.1e rested by. J.S.my

Approved by: D.H.Kang /Manager& Chief Engin

D-H-Kang

/Manager& Chief Engineer

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Test Result:

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The above mentioned product has been tested and passed.

Signature Date Signature Date Signature Date

Other Aspects:

Abbreviations : • OK, Pass = passed • Fail = failed • N/A = not applicable

- •This test report is not permitted to copy partly without our permission.
 - •This test result is dependent on only equipment to be used.
 - •This test result is based on a single evaluation of one sample of the above mentioned.
 - •This test report must not be used by the client to claim product endorsement by NVLAP or any agency of the U.S Government.
 - We certify that this test report has been based on the measurement standards that is traceable to the national or International standards.

NVLAP Lab. Code: 200220-0



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1. General

This equipment has been shown to be capable of compliance with the applicable technical standards and was tested in accordance with the measurement procedures as indicated in this report.

We attest to the accuracy of data. All measurements reported herein were performed by SK Tech Co., Ltd. and were made under Chief Engineer's supervision.

We assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

2. Test Site

SK TECH Co., Ltd.

2.1 Location

820-2, Wolmoon Ri, Wabu-Up, Namyangju-Si, Kyunggi-Do, Korea

The test site is in compliance with ISO/IEC 17025 for general requirements for the competence of testing and calibration laboratories.

This laboratory is accredited by NVLAP for NVLAP Lab. Code: 200220-0 and DATech for DAR-Registration No.:DAT-P-076/97-01



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2.2 List of Test and Measurement Instruments

Table 1: List of Test and Measurement Equipment

Conducted Disturbance

Kind of Equipment	Туре	S/N	Calibrated until
EMI Receiver	ESHS10	862970/019	10.2005
Artificial Mains Network	ESH2-Z5	834549/011	08.2006
EMI Receiver	ESHS10	835871/002	10.2005
Artificial Mains Network	ESH3-Z5	836679/018	08.2006

Radiated Disturbance

Kind of Equipment	Туре	S/N	Calibrated until
EMI Receiver	ESVS 10	825120/013	10.2005
EMI Receiver	ESVS 10	834468/008	11.2005
Spectrum Analyzer	R3361A	11730187	10.2005
Amplifier	8447F	3113A05153	08.2006
Log Periodic Antenna	UHALP9107	1819	10.2005
Biconical Antenna	BBA9106	91031626	10.2005
Open Site Cable	N/A	N/A	N/A
Antenna Turntable Driver	5907	N/A	N/A
Antenna Turntable controller	5906	N/A	N/A
Amp & Receiver connection cable	N/A	N/A	N/A
Amp & Spectrum connection cable	N/A	N/A	N/A
50 Ω Switcher	MP59B	6100214538	N/A

2.3 Test Date

Date of Application : Aug 26, 2005

Date of Test : Aug 29, 2005 ~ Sep 06, 2005

2.4 Test Environment

See each test item's description.



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3. Description of the tested samples

The EUT is the Keyboard.

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3.1 Rating and Physical Characteristics

ELECTRICAL REQUIREMEN	NTS
Operating voltage range	DC 5V ±0.25
Operating current	Max 100mA
Insulation resistance	More than 100M ohm at 250V DC
Contact resistance	2K Ω or less
Chattering and bounce	Operation force shall be applied according to the normal Method at 5V DC, 5mA. There shall be no bounce and Chattering within 10msec when it is measured using a specially prepared tester or a synchroscope.
ENVIRONMENTAL REQUIR	EMENTS
Operational ambient	Temperature: 0~50 ℃
Temperature and humidity	Humidity: 85%RH
Storage ambient	Temperature: -20~60 ℃
Temperature an humidity	Humidity: 98%RH
Shock	There shall be no abnormally in operation and appearance of the keyboard when an impact of 10G has been applied to the package keyboard. The testing method shall be in accordance with 213B of MIL-STD-202E
Vibration	The keyboard shall not be damaged electrically and Mechanically when the following vibration has been Applied to the packaged keyboard. The testing method shall be in accordance with 201A of MIL-STD-202E. Frequency: 10~55Hz Amplitude: 0.5mm
	Direction of vibration: Direction X, Y and Z individually
	Time of vibration: 2hours

3.2 Submitted Documents

N/A



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4. Measurement Conditions

Operating voltage of the EUT is 120V, 60Hz

4.1 Modes of Operation

During test, the EUT printed "H" character continuously

4.2 List of Peripherals

Equipment	Equipment Manufacturer Model Nam		Serial No.
EUT	SEJIN ELECTRON INC.	SKR-4200U	N/A
Note PC	Note PC LG IBM PC		FX-P2816
Printer(Parallel)	EPSON PRECISION (PHILIPPINES),INC.	EPSON STYLUS PHOTO 830	ELTK014637



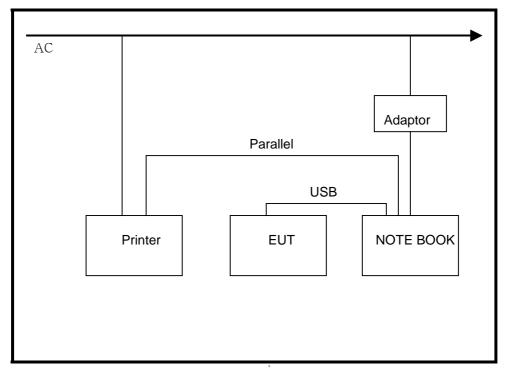
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4.3 Type of Used Cables

Equipment	Manufacturer	M/N	S/N	Cables &connectors
EUT	SEJIN ELECTRON INC.	SKR-4200U	N/A	1.4m USB cable Unshielded (For Note PC)
Printer(Parallel)	EPSON PRECISION (PHILIPPINES),INC.	EPSON STYLUS PHOTO 830	ELTK014637	1.4m Power cable Unshielded (For Note PC)
Note PC	LG IBM PC	2681	FX-P2816	1.2m Parallel cable Shielded (For Printer) 1.4m Power cable Unshielded (For Power)

4.4 Test Setup

The test setup photographs showed the external supply connections and interfaces.



[System Block Diagram of Test Configuration]



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4.5 Uncertainty

1) Radiated disturbance

• Horizontally polarized radiated disturbances from 30MHz to 1000MHz at a distance of 10m

	Uncertainty of Xi		U(Xi)			
Input quantity	dB	Probability distribution function	dB	Ci	Ciu(xi)	CISPR 16-4
1) Receiver reading	±0.1	K =1	0.1	1	0.1	0.10
2) Attenuation: antenna-receiver	±0.18	K=2	0.09	1	0.09	0.05
3) Antenna factor	±1.5	K=2	0.75	1	0.75	1.00
RECEIVER CORRECTIONS:						
4) Sine wave voltage	±0.56	K=2	0.28	1	0.50	0.50
5) Pulse amplitude response	±1.5	Rectangular (√3)	0.87	1	0.87	0.87
6) Pulse repetition rate response	±1.5	Rectangular (√3)	0.87	1	0.87	0.87
7) Noise floor proximity	±0.5	K=2	0.25	1	0.25	0.25
8) AF frequency interpolation	±0.3	Rectangular $(\sqrt{3})$	0.17	1	0.17	0.17
9) Balance	±0.3	Rectangular (√3)	0.17	1	0.17	0.53
10) AF height deviations	±0.5	Rectangular $(\sqrt{3})$	0.29	1	0.29	0.29
11) Phase center location	±0.3	Rectangular $(\sqrt{3})$	0.17	1	0.17	0.17
12) Directive difference	+1.0	Rectangular $(\sqrt{3})$	0.29	1	0.29	0.29
13) Cross polarization	±0.9	Rectangular $(\sqrt{3})$	0.52	1	0.52	0.52
14) Site corrections	±2.6	Rectangular $(\sqrt{3})$	1.5	1	1.5	1.63
15) Mismatch (ant-receiver)	±1.06	U-shaped (√2)	0.75	1	0.75	0.67

Combined Uncertainty

$$Uc(xi) = \sqrt{(1)^2 + (2)^2 + (3)^2 + (4)^2 + (5)^2 + (6)^2 + (7)^2 + (8)^2 + (9)^2 + (10)^2 + (11)^2 + (12)^2} + (13)^2 + (14)^2 + (15)^2 = 2.37$$

Expanded Uncertainty

U= k*Uc(xi) = 2 * 2.37= 4.74dB (The coverage factor k = 2 yields approximately a 95% level of confidence)



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• Vertically polarized radiated disturbances from 30MHz to 1000 MHz at a distance of 10 m

	Unce	ertainty of Xi	U(Xi)			
Input quantity	15	Probability	O(XI)	Ci	Ciu(xi)	CISPR
	dB	distribution function	dB			16-4
1) Receiver reading	±0.1	K =1	0.1	1	0.1	0.10
2) Attenuation: antenna-receiver	±0.18	K=2	0.09	1	0.09	0.05
3) Antenna factor	±1.5	K=2	0.75	1	0.75	1.00
RECEIVER CORRECTIONS:						
4) Sine wave voltage	±0.56	K=2	0.28	1	0.50	0.50
5) Pulse amplitude response	±1.5	Rectangular (√3)	0.87	1	0.87	0.87
6) Pulse repetition rate response	±1.5	Rectangular (√3)	0.87	1	0.87	0.87
7) Noise floor proximity	±0.5	K=2	0.25	1	0.25	0.25
8) AF frequency interpolation	±0.3	Rectangular (√3)	0.17	1	0.17	0.17
9) Balance	±0.9	Rectangular (√3)	0.52	1	0.52	0.52
10)AF height deviations	±0.3	Rectangular (√3)	0.17	1	0.17	0.17
11) phase center location	±0.3	Rectangular (√3)	0.17	1	0.17	0.17
12) directive difference	+1.0	Rectangular (√3)	0.29	1	0.29	0.29
13)cross polarization	±0.9	Rectangular (√3)	0.52	1	0.52	0.52
14) site corrections	±2.6	Rectangular (√3)	1.5	1	1.5	1.63
15) Mismatch (ant-receiver)	±1.06	U-shaped (√2)	0.75	1	0.75	0.67

Combined Uncertainty

$$Uc(xi) = \sqrt{(1)^2 + (2)^2 + (3)^2 + (4)^2 + (5)^2 + (6)^2 + (7)^2 + (8)^2 + (9)^2 + (10)^2 + (11)^2 + (12)^2 + (14)^2 + (15)^2} = 2.43$$

Expanded Uncertainty

 $U = k^*Uc(xi) = 2 * 2.43 = 4.86dB$

(The coverage factor k =2 yields approximately a 95% level of confidence)



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2) Conducted disturbance

 \odot Conducted disturbance from 150 KHz to 30 MHz using a 50 Ω / 50 uH AMN

	Uı	ncertainty of Xi				
input quantity	dB	Probability distribution function	U(Xi) dB	Ci	Ciu(xi)	CISPR 16-4
1) Receiver Readeing	±0.1	K =1	0.1	1	0.1	0.10
2) Attenuation:AMN-receiver	±0.36	Triangular (√6)	0.15	1	0.15	0.05
RECEIVER CORRECTIONS:						
3) Sine wave voltage	±0.5	K=2	0.25	1	0.25	0.50
4) Pulse amplitude response	±1.5	Rectangular (√3)	0.87	1	0.87	0.87
5) Pulse repetition rate response	±1.5	Rectangular (√3)	0.87	1	0.87	0.87
6) AMN voltage division factor	±0.07	K=2	0.04	1	0.04	0.1
7) Mismatch : AMN-receiver	±0.55	U-shaped $(\sqrt{2})$	0.39	1	0.39	0.53
8) AMN impedance	±1.52	Triangular (√6)	0.62	1	0.62	1.08

• 1)~8) For numbered comments, refer to following articles

Combined Uncertainty

$$Uc(xi) = \sqrt{(1)^2 + (2)^2 + (3)^2 + (4)^2 + (5)^2 + (6)^2 + (7)^2 + (8)^2} = 1.47$$

Expanded uncertainty

$$U = k^*Uc(xi) = 2 * 1.47 = 2.94dB$$

The coverage factor k =2 yields approximately a 95% level of confidence

Refer

- 1) receiver's resolution capacity
- 2) refer to the sub clause 11. of a calibration report
- 3) quoted from CISPR 16-4
- 4) refer to a calibration report
- 5) refer to CISPR 16-4 article 5.7)
- 6) refer to a calibration report and a measured AMN impedance data



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5. EMISSION Test

5.1 Conducted Emissions

Result: PASS

The line-conducted facility is located inside a 2.6M x 3.6M x 7.0M shielded enclosure.

The shielding effectiveness of the shielded room is in accordance with MIL-Std-285 or NSA 604-05.

A 1 m x 1.5 m wooden table 80 cm high is placed 40 cm. away from the vertical wall and 1.5 m away from the side wall of the shielded room. ROHDE & SCHWARZ Model ESH3-Z5 (10 kHz-30 MHz) 50 ohm/50 uH Line-Impedance Stabilization Networks(LISNs) are bonded to the shielded room.

The EUT is powered from the ROHDE & SCHWARZ LISN and the support equipment is powered from the ROHDE & SCHWARZ LISN. Power to the LISNs are filtered by a high-current high-insertion loss Lindgren enclosures power line filters (100dB 14 kHz-10 GHz).

The purpose of the filter is to attenuate ambient signal interference and this filter is also bonded to the shielded enclosure.

All electrical cables are shielded by braided tinned copper zipper tubing with inner diameter of 1/2". If the EUT is a DC-powered device, power will be derived from the source power supply it normally will be powered from and this supply lines will be connected to the ROHDE & SCHWARZ LISN. All interconnecting cables more than 1 meter were shortened by non-inductive bundling (serpentine fashion) to a 1-meter length.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer to determine the frequency producing the maximum EME from the EUT.

The spectrum was scanned from 150 kHz to 30 MHz with 100msec. sweep time.

The frequency producing the maximum level was reexamined using EMI/field Intensity Meter (ESHS 10) and Quasi-Peak adapter. The detector function was set to CISPR quasi-peak mode.

The bandwidth of the receiver was set to 10 kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each EME emission.

Each emission was maximized by: switching power lines; varying the mode of operation or resolution; clock or data exchange speed; if applicable; whichever determined the worst-case emission.

Photographs of the worst-case emission can be seen in photograph of conducted test.

Each EME reported was calibrated using self-calibrating mode.



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Figure 1 : Spectral Diagram, LINE - PE

07 Sep 2005 17:00

CONDUCTED DISTURBANCE

EUT: SKR-4200U

Manuf: Op Cond: Operator: Test Spec:

Comment: LINE-PE

Result File: SKR_L.dat : New Measurement

Scan Settings (1 Range)

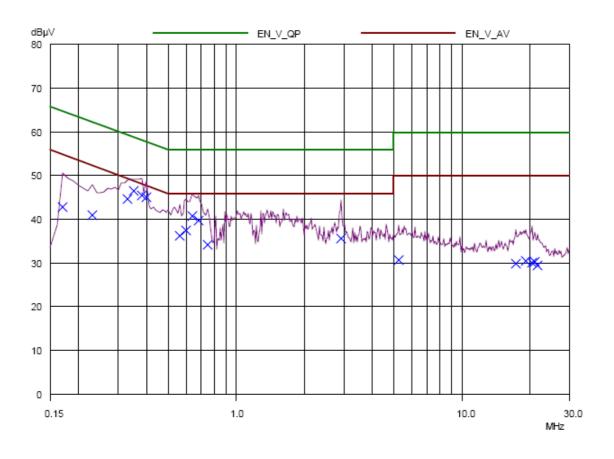
 Frequencies Receiver Settings -Start Step IF BW Detector M-Time Atten OpRge Stop Preamp 150kHz 30MHz 10kHz 10kHz 100msec Auto OFF 60dB

Final Measurement: Detector: X QP

 Meas Time:
 1sec

 Peaks:
 8

 Acc Margin:
 35 dB





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Figure 2: Test Data, LINE – PE

07 Sep 2005 17:00

CONDUCTED DISTURBANCE

EUT: SKR-4200U

Manuf: Op Cond: Operator: Test Spec:

Comment: LINE-PE

Result File: SKR_L.dat : New Measurement

Scan Settings (1 Range)

- Frequencies -— Receiver Settings -IF BW Detector M-Time Atten Step Start Preamp OpRge Stop 150kHz 30MHz 10kHz 10kHz PΚ 100msec Auto OFF 60dB

Final Measurement: Detector: X QP
Meas Time: 1sec

Peaks: 8
Acc Margin: 35 dB

Final Measurement Results

Frequency	QP Level	QP Limit	QP Dett
MHz	dBµ∀	dBµ∀	dB
0.17	42.83	64.96	22.13
0.23	40.97	62.45	21.48
0.33	44.84	59.45	14.61
0.35	46.64	58.96	12.32
0.38	45.62	58.28	12.66
0.4	45.12	57.85	12.73
0.56	36.39	56.00	19.61
0.6	37.46	56.00	18.54
0.64	40.91	56.00	15.09
0.68	39.81	56.00	16.19
0.75	34.26	56.00	21.74
2.91	35.66	56.00	20.34
5.27	30.76	60.00	29.24
17.35	29.99	60.00	30.01
19.16	30.56	60.00	29.44
20.44	30.09	60.00	29.91
21.01	30.43	60.00	29.57
21.68	29.44	60.00	30.56

^{*} limit exceeded



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Figure 3: Spectral Diagram, NEUTRAL - PE

07 Sep 2005 16:05

CONDUCTED DISTURBANCE

EUT: SKR-4200U

Manuf: Op Cond: Operator: Test Spec:

Comment: NEUTRAL-PE

Result File: SKR_N.dat : New Measurement

Scan Settings (1 Range) Frequencies

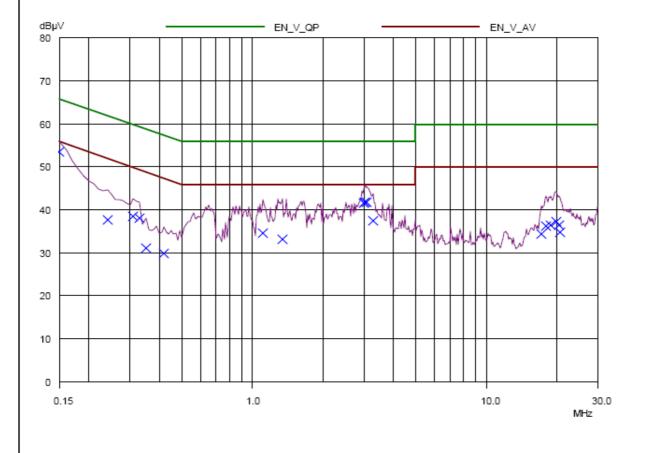
 Receiver Settings -Start Stop Step IF BW Detector M-Time Atten OpRge Preamp 150kHz 30MHz 10kHz 10kHz PΚ 100msec Auto OFF 60dB

Final Measurement: Detector: X QP

 Meas Time:
 1 sec

 Peaks:
 8

 Acc Margin:
 35 dB





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Figure 4: Test Data, NEUTRAL - PE

07 Sep 2005 16:05

CONDUCTED DISTURBANCE

SKR-4200U

Manuf: Op Cond: Operator: Test Spec:

Comment:

NEUTRAL-PE

Result File:

Start

150kHz

SKR_N.dat : New Measurement

Scan Settings

(1 Range)

 Frequencies Stop 30MHz

Step 10kHz

IF BW Detector M-Time Atten Preamp OpRge — Receiver Settings — 100msec Auto

60dB

Final Measurement:

Detector: Meas Time: X QP 1sec

Peaks: 8 Acc Margin: 35 dB

Final Measurement Results

Frequency	QP Level	QP Limit	QP Deta
MHz	dBµ∀	dBµ∨	dB
0.15	53.49	66.00	12.51
0.24	37.83	62.10	24.27
0.31	38.53	59.97	21.44
0.33	38.19	59.45	21.26
0.35	31.17	58.96	27.79
0.42	29.90	57.45	27.55
1.11	34.62	56.00	21.38
1.35	33.27	56.00	22.73
3.0	41.60	56.00	14.40
3.01	41.78	56.00	14.22
3.08	41.89	56.00	14.11
3.28	37.58	56.00	18.42
17.27	34.48	60.00	25.52
18.0	36.35	60.00	23.65
18.8	36.51	60.00	23.49
19.85	37.44	60.00	22.56
20.39	36.43	60.00	23.57
20.75	34.90	60.00	25.10

^{*} limit exceeded



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5.2 Radiated Emissions

Result: PASS

Preliminary measurements were made indoors at 3 meter using broadband antennas, broadband amplifier, and spectrum analyzer to determine the frequency producing the maximum EME. Appropriate precaution was taken to ensure that all EME from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna were noted for each frequency found.

The spectrum was scanned from 30 to 300 MHz using biconical antenna and from 300 to 1000 MHz using log-periodic antenna. Above 1 GHz, linearly polarized double ridge horn antennas were used.

Final measurements were made outdoors at 3-meter test range using SCHWARZBECK dipole antennas. The test equipment was placed on a wooden table situated on a 4x4 meter area adjacent to the measurement area. Turntable was to protect from weather in the dome that made with FRP. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. Each frequency found during pre-scan measurements was re-examined and investigated using EMI/Field Intensity Meter(ESVS 10) and Quasi-Peak Adapter. The detector function was set to CISPR quasi-peak mode and the bandwidth of the receiver was set to 100 kHz or 1 MHz depending on the frequency or type of signal.

The half-wave dipole antenna was tuned to the frequency found during preliminary radiated measurements. The EUT, support equipment and interconnecting cables were re-configured to the set-up producing the maximum emission for the frequency and were placed on top of a 0.8-meter high non-metallic 1 x 1.5 meter table.

The EUT, support equipment, and interconnecting cables were re-arranged and manipulated to maximize each EME emission. The turntable containing the system was rotated; the antenna height was varied 1 to 4 meters and stopped at the azimuth or height producing the maximum emission. Each emission was maximized by: varying the mode of operation or resolution; clock or data exchange speed, and/or support equipment, if applicable; and changing the polarity of the antenna, whichever determined the worst-case emission.

Photographs of the worst-case emission can be seen in photograph of radiated emission test. Each EME reported was calibrated using self-calibrating mode.



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Table 2: Test Data, Radiated Emissions

Frequency	Pol.	Height	Real	Correction Factor		T-Fact	Data	Limits	Margin
[MHz]		[m]	Reading	Antenna	Cable	[dB]	[dBuV/m]	[dBuV/m]	[dB]
74.24	Н	4.0	18.5	5.9	1.1	7.0	25.5	30.0	4.5
120.47	Н	4.0	7.9	13.1	1.7	14.8	22.7	30.0	7.3
168.45	Н	4.0	3.9	15.4	2.1	17.5	21.4	30.0	8.6
219.86	Н	4.0	4.3	16.9	2.6	19.5	23.8	30.0	6.2

NOTES:

- 1. All modes of operation were investigated and the worst-case emission are reported.
- 2. All other emission are non-significant.
- 3. All readings are calibrated by self-mode in receiver.
- 4. Measurements using CISPR quasi-peak mode.
- 5. H = Horizontal, V = Vertical Polarization
- 6. DATA = Real Reading + T FACTOR(=Antenna+Cable)
- 7. Margin = Limits DATA